

Linear Systems replaces discontinued Siliconix & National 2N5911

The LS5911 are monolithic dual JFETs. The monolithic dual chip design reduces parasitics and gives better performance at very high frequencies while ensuring extremely tight matching. These devices are an excellent choice for use as wideband differential amplifiers in demanding test and measurement applications. The LS5911 is a direct replacement for discontinued Siliconix and National 2N5911.

The 6 Pin SOT-23 provides ease of manufacturing, and a lower cost assembly option.
(See Packaging Information).

LS5911 Applications:

- Wideband Differential Amps
- High-Speed, Temp-Compensated Single-Ended Input Amps
- High-Speed Comparators
- Impedance Converters and vibrations detectors.

FEATURES	
Improved Direct Replacement for SILICONIX & NATIONAL 2N5911	
LOW NOISE (10KHz)	$e_n \sim 4\text{nV}/\sqrt{\text{Hz}}$
HIGH TRANSCONDUCTANCE (100MHz)	$g_{fs} \geq 4000\mu\text{S}$
ABSOLUTE MAXIMUM RATINGS ¹ @ 25°C (unless otherwise noted)	
Maximum Temperatures	
Storage Temperature	-65°C to +150°C
Operating Junction Temperature	-55°C to +135°C
Maximum Power Dissipation	
Continuous Power Dissipation (Total)	500mW
Maximum Currents	
Gate Current	50mA
Maximum Voltages	
Gate to Drain	-25V
Gate to Source	-25V

MATCHING CHARACTERISTICS @ 25°C (unless otherwise stated)

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
$ V_{GS1} - V_{GS2} $	Differential Gate to Source Cutoff Voltage	--	--	10	mV	$V_{DG} = 10\text{V}, I_D = 5\text{mA}$
$\Delta V_{GS1} - V_{GS2} / \Delta T$	Differential Gate to Source Cutoff Voltage Change with Temperature	--	--	20	$\mu\text{V}/^\circ\text{C}$	$V_{DG} = 10\text{V}, I_D = 5\text{mA}$ $T_A = -55^\circ\text{C}$ to $+125^\circ\text{C}$
I_{DSS1} / I_{DSS2}	Gate to Source Saturation Current Ratio	0.95	--	1	%	$V_{DS} = 10\text{V}, V_{GS} = 0\text{V}$
$ I_{G1} - I_{G2} $	Differential Gate Current	--	--	20	nA	$V_{DG} = 10\text{V}, I_D = 5\text{mA}$ $T_A = +125^\circ\text{C}$
g_{fs1} / g_{fs2}	Forward Transconductance Ratio ²	0.95	--	1	%	$V_{DS} = 10\text{V}, I_D = 5\text{mA}, f = 1\text{kHz}$
CMRR	Common Mode Rejection Ratio	--	85	--	dB	$V_{DG} = 5\text{V}$ to $10\text{V}, I_D = 5\text{mA}$

ELECTRICAL CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTICS	MIN.	TYP.	MAX.	UNITS	CONDITIONS
BV_{GSS}	Gate to Source Breakdown Voltage	-25	--	--	V	$I_G = -1\mu\text{A}, V_{DS} = 0\text{V}$
$V_{GS(off)}$	Gate to Source Cutoff Voltage	-1	--	-5		$V_{DS} = 10\text{V}, I_D = 1\text{nA}$
$V_{GS(F)}$	Gate to Source Forward Voltage	--	0.7	--		$I_G = 1\text{mA}, V_{DS} = 0\text{V}$
V_{GS}	Gate to Source Voltage	-0.3	--	-4		$V_{DG} = 10\text{V}, I_G = 5\text{mA}$
I_{DSS}	Gate to Source Saturation Current ³	7	--	40	mA	$V_{DS} = 10\text{V}, V_{GS} = 0\text{V}$
I_{GSS}	Gate Leakage Current ³	--	-1	-50	pA	$V_{GS} = -15\text{V}, V_{DS} = 0\text{V}$
I_G	Gate Operating Current	--	-1	-50		$V_{DG} = 10\text{V}, I_D = 5\text{mA}$
g_{fs}	Forward Transconductance	4000	--	10000	μS	$V_{DG} = 10\text{V}, I_D = 5\text{mA}$
		4000	--	10000		
g_{os}	Output Conductance	--	--	100		
		--	--	150		
C_{ISS}	Input Capacitance	--	--	5	pF	$V_{DG} = 10\text{V}, I_D = 5\text{mA}, f = 1\text{MHz}$
C_{RSS}	Reverse Transfer Capacitance	--	--	1.2		
NF	Noise Figure	--	--	1	dB	$V_{DG} = 10\text{V}, I_D = 5\text{mA}, f = 10\text{kHz}, R_G = 100\text{K}\Omega$
e_n	Equivalent Input Noise Voltage	--	7	20	nV/ $\sqrt{\text{Hz}}$	$V_{DG} = 10\text{V}, I_D = 5\text{mA}, f = 100\text{Hz}$
		--	4	10		$V_{DG} = 10\text{V}, I_D = 5\text{mA}, f = 10\text{kHz}$
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Notes: 1. Absolute Maximum ratings are limiting values above which serviceability may be impaired

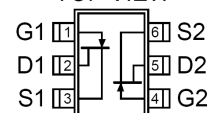
2. Pulse Test: $PW \leq 300\mu\text{s}$ Duty Cycle $\leq 3\%$

3. Assumes smaller value in numerator

Available Packages:

LS5911 in SOT-23
LS5911 available as bare die

SOT-23
TOP VIEW



Please contact Micross for full package and die dimensions:

Email: chipcomponents@micross.com

Web: www.micross.com/distribution.aspx